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	Diffraction; Fraunhofer Diffraction; 4.4 Fraunhofer Diffraction from a Thin Lens; 4.5 Thin Lens Optical System Diffraction Psf; 4.6 Thin Lens Diffraction Mtf; Modulation and Modulation Transfer Function; Incoherent Diffraction MTF; Coherent Diffraction MTF; 4.7 Calculating Diffraction Mtf with Pencil and Paper; Circular Pupil: Coherent MTF; Circular Pupil: Incoherent MTF; 4.8 Programs for Calculating Incoherent Diffraction Mtf; 4.9 Applications of Diffraction Theory; 4.10 Exercises; References; Chapter 5 Sources of Radiation. 5.1 Radiometry and PhotometryRadiometric Units; Photometric Units; 5.2 Infrared Targets and Backgrounds; Blackbody Radiation; Emissivity; Equivalent Differential Temperature (Delta T); Apparent Differential Temperature (Apparent Delta T); Technique 1: Temperature-Broadband Beer's Law Product; Technique 2: Temperature-Broadband Beer's Law Product; Technique 4: Flux-Temperature Differential; 5.3 Electro-Optical Targets and Backgrounds; External Sources; Contrast; 5.4 Other Sensitivity Considerations. Bidirectional Reflectance Distribution FunctionColor Considerations; 5.5 Target and Background Spatial Characteristics; Bar Target Representation of Targets; Target Delta T and Characteristic Dimension; Summary of Target Characteristics; Clutter; Simulation of Target Characteristics; 5.6 Typical Midwave and Longwave Contrasts and Solar Effects; 5.7 Exercises; References; Chapter 6 Atmospherics; 6.1 Atmospheric Components and Structure; 6.2 Atmospheric Transmission; 6.3 Absorption; 6.4 Scattering; 6.5 Path Radiance; 6.6
Sommario/riassunto	Turbulence; 6.7 Atmospheric MTF; 6.8 Models; 6.9 Model Discussion. This newly revised and updated edition of a classic Artech House book offers a current and complete introduction to the analysis and design of Electro-Optical (EO) imaging systems. The Second Edition provides numerous updates and brand new coverage of today's most important areas, including the integrated spatial frequency approach and a focus on the weapons of terrorists as objects of interest. This comprehensive reference details the principles and components of the Linear Shift- Invariant (LSI) infrared and electro-optical systems and shows you how to combine this approach with calculus and d.